

Application/Control No.	Applicant(s)/Patent under Reexamination
10/510 754	OKA IIMA ET AL

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xaminer	Art Unit	
aura M. Lee	3724	

SEARCHED				
Class	Subclass	Date	Examiner	
83	861-887	8/3/2007	LML	
225	2, 96-104	8/3/2007	LML	
65	105, 174	8/3/2007	LML	
65	112	8/3/2007	LML	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East Search, Text Search, Inventor Name Search, Considered the IDSs	8/3/2007	LML